

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at www.onsemi.com

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA Class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, emplo



April 2013

FQP47P06

P-Channel QFET® MOSFET

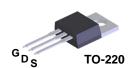
- 60 V, - 47 A, 26 mΩ

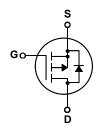
Description

This P-Channel enhancement mode power MOSFET is produced using Fairchild Semiconducto®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- 47 A, 60 V, $R_{DS(on)}$ = 26 m Ω @ V_{GS} = 10 V, I_D = 23.5 A
- Low Gate Charge (Typ. 84 nC)
- Low Crss (yp. 320 pF)
- 100% Avalanche Tested
- 175°C Maximum Junction Temrature Rating.





Absolute Maximum Ratings $T_C = 25$ °C unless otherwise noted

Symbol	Parameter		FQP47P06	Unit
V _{DSS}	Drain-Source Voltage		-60	V
I _D	Drain Current - Continuous (T _C = 25°C)		-47	А
	- Continuous (T _C = 10	O°C)	-33.2	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-188	А
V _{GSS}	Gate-Source Voltage		± 25	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	820	mJ
I _{AR}	Avalanche Current	(Note 1)	-47	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	16	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-7.0	V/ns
P_D	Power Dissipation ($T_C = 25^{\circ}C$)		160	W
- Derate above 25°C			1.06	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	FQP47P06	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.94	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink, Typ.	0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	°C/W

$ \begin{array}{c} BV_{DSS} \\ \Delta T_{J} \\ Coefficient \\ \\ SS \\ \Delta T_{J} \\ Coefficient \\ \\ SS \\ \Delta T_{J} \\ Coefficient \\ \\ SS \\ Zero Gate Voltage Drain Current \\ \hline \\ V_{DS} = -60 \text{ V}, V_{GS} = 0 \text{ V} \\ \hline \\ V_{DS} = -48 \text{ V}, T_{C} = 150^{\circ}\text{C} \\ \hline \\ V_{DS} = -48 \text{ V}, T_{C} = 150^{\circ}\text{C} \\ \hline \\ V_{DS} = -48 \text{ V}, T_{C} = 150^{\circ}\text{C} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -23.5 \text{ A} \\ \hline \\ V_{DS} = -23.5 \text{ A} \\ \hline \\ V_{DS} = -23.5 \text{ A} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -23.5 \text{ A} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 $		Parameter	Test Conditions	Min	Тур	Max	Unit
VDSS Drain-Source Breakdown Voltage $V_{GS} = 0 \text{ V}$, $I_{D} = -250 \mu\text{A}$ -60 $$ V_{C} BVDSS AT User Coefficient Ip = -250 μA, Referenced to 25°C $$ -0.06 $$ V_{C} SSS Zero Gate Voltage Drain Current $V_{DS} = -60 \text{ V}$, $V_{GS} = 0 \text{ V}$ $$	Off Cha	aracteristics					
$ \begin{array}{c} BV_{DSS} \\ \Delta T_{J} \\ Coefficient \\ \\ SS \\ \Delta T_{J} \\ Coefficient \\ \\ SS \\ \Delta T_{J} \\ Coefficient \\ \\ SS \\ Zero Gate Voltage Drain Current \\ \hline \\ V_{DS} = -60 \text{ V}, V_{GS} = 0 \text{ V} \\ \hline \\ V_{DS} = -48 \text{ V}, T_{C} = 150^{\circ}\text{C} \\ \hline \\ V_{DS} = -48 \text{ V}, T_{C} = 150^{\circ}\text{C} \\ \hline \\ V_{DS} = -48 \text{ V}, T_{C} = 150^{\circ}\text{C} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -23.5 \text{ A} \\ \hline \\ V_{DS} = -23.5 \text{ A} \\ \hline \\ V_{DS} = -23.5 \text{ A} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -23.5 \text{ A} \\ \hline \\ V_{DS} = -25 \text{ V}, V_{DS} = 0 \text{ V} \\ \hline \\ V_{DS} = -25 $	BV _{DSS}		V _{GS} = 0 V, I _D = -250 μA	-60			V
Zero Gate Voltage Drain Current V _{DS} = -48 V, T _C = 150°C -10 μ/V _{DS} = -48 V, T _C = 150°C -10 μ/V _{DS} = -25 V, V _{DS} = 0 V -100 n/V _{DS} = -25 V, V _{DS} = 0 V 100 n/V _{DS} = -25 V, V _{DS} = 0 V 100 n/V _{DS} = -25 V, V _{DS} = 0 V 100 n/V _{DS} = -25 V, V _{DS} = 0 V 100 n/V _{DS} = -25 V, V _{DS} = 0 V 100 n/V _{DS} = -25 V, V _{DS} = 0 V 100 n/V _{DS} = -25 V, V _{DS} = 0 V 100 n/V _{DS} = -20 V, V _{DS} = -25 V, V _{DS} = 0 V, V _{DS} = 0 V, V _{DS} = -25 V, V _{DS} = 0 V, V _{DS} = 0 V, V _{DS} = 0 V, V _{DS} = -25 V, V _{DS} = 0 V	ΔBV _{DSS}	Breakdown Voltage Temperature			-0.06		V/°C
V _{DS} = -48 V, I _C = 150°C -10 μ/sss Gate-Body Leakage Current, Forward V _{GS} = -25 V, V _{DS} = 0 V -100 n/sss Gate-Body Leakage Current, Reverse V _{GS} = 25 V, V _{DS} = 0 V 100 n/s	I _{DSS}	Zero Onto Valta va Basis Oceana	V _{DS} = -60 V, V _{GS} = 0 V			-1	μΑ
Sess Gate-Body Leakage Current, Reverse V _{GS} = 25 V, V _{DS} = 0 V 100 n/s		Zero Gate Voltage Drain Current	V _{DS} = -48 V, T _C = 150°C			-10	μΑ
On Characteristics GS(th) Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_{D} = -250 \mu\text{A}$ -2.0 -4.0 V DS(on) Static Drain-Source On-Resistance $V_{GS} = -10 \text{V}$, $I_{D} = -23.5 \text{A}$ 0.021 0.026 Ω Con-Resistance $V_{DS} = -30 \text{V}$, $I_{D} = -23.5 \text{A}$ 21 S Dynamic Characteristics Input Capacitance $V_{DS} = -25 \text{V}$, $V_{GS} = 0 $	I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -25 V, V _{DS} = 0 V			-100	nA
GS(th) Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \mu A$ -2.0 -4.0 V DS(on) Static Drain-Source On-Resistance $V_{GS} = -10 \text{V}$, $I_D = -23.5 \text{A}$ 0.021 0.026 Ω PS Forward Transconductance $V_{DS} = -30 \text{V}$, $I_D = -23.5 \text{A}$ (Note 4) 21 S PS Input Capacitance $V_{DS} = -25 \text{V}$, $V_{GS} = 0 \text{V}$, $V_{GS} = 0 $	I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 25 V, V _{DS} = 0 V			100	nA
GS(th) Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \mu A$ -2.0 -4.0 V DS(on) Static Drain-Source On-Resistance $V_{GS} = -10 \text{V}$, $I_D = -23.5 \text{A}$ 0.021 0.026 Ω PS Forward Transconductance $V_{DS} = -30 \text{V}$, $I_D = -23.5 \text{A}$ (Note 4) 21 S PS Input Capacitance $V_{DS} = -25 \text{V}$, $V_{GS} = 0 \text{V}$, $V_{GS} = 0 $	On Cha	aracteristics					
DS(on) Static Drain-Source On-Resistance $V_{GS} = -10 \text{ V}$, $I_D = -23.5 \text{ A}$ 0.021 0.026 Ω PS Forward Transconductance $V_{DS} = -30 \text{ V}$, $I_D = -23.5 \text{ A}$ (Note 4) 21 S Pynamic Characteristics Input Capacitance $V_{DS} = -25 \text{ V}$, $V_{GS} = 0 \text{ V}$, $I_D = -23.5 \text{ A}$, $I_D =$	V _{GS(th)}	+	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-2.0		-4.0	V
tynamic Characteristics siss Input Capacitance $V_{DS} = -25 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1.0 \text{ MHz}$	R _{DS(on)}		V _{GS} = -10 V, I _D = -23.5 A		0.021	0.026	Ω
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	9 _{FS}	Forward Transconductance	$V_{DS} = -30 \text{ V}, I_D = -23.5 \text{ A}$ (Note 4)		21		S
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Coss	' '	f = 1.0 MHz				pF
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		' '	f = 1.0 MHz				
Turn-On Rise Time $V_{DD} = -30 \text{ V, } I_{D} = -23.5 \text{ A,}$ $C_{DD} = -30 \text{ V, } I_{D} = $	C _{rss}	<u>'</u>			0_0	420	рі
Turn-On Rise Time $R_{G} = 25 \ \Omega$ 450 910 ns		ing Characteristics			020	420	рі
(off) Turn-Off Delay Time 100 210 ns Turn-Off Fall Time (Note 4, 5) 195 400 ns	Switchi	1	V-n = -30 V In = -23 5 A			1	ns
		Turn-On Delay Time			50	110	•
g Total Gate Charge V _{DS} = -48 V, I _D = -47 A, 84 110 nC	Switchi	Turn-On Delay Time Turn-On Rise Time			50 450	110 910	ns
	Switchi $t_{d(on)}$ t_r $t_{d(off)}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	$R_G = 25 \Omega$		50 450 100	110 910 210	ns ns
Gate-Source Charge $V_{GS} = -10 \text{ V}$ 18 nC	Switchi $t_{d(on)}$ t_r $t_{d(off)}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	$R_G = 25 \Omega$	 	50 450 100 195	110 910 210 400	ns ns
	Switchi td(on) tr tf td(off) tg Qg	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_G = 25 \ \Omega$ (Note 4, 5) $V_{DS} = -48 \ V$, $I_D = -47 \ A$,	 	50 450 100 195 84	110 910 210 400 110	ns ns ns
					323	420	
	Switchi td(on) tr td(off) tf Qg Qgs	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = -48 \text{ V}, I_D = -47 \text{ A}, V_{GS} = -10 \text{ V}$	 	50 450 100 195 84 18	110 910 210 400 110	ns ns ns ns
	Switchi td(on) tr td(off) tf Qg Qgs	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = -48 \text{ V}, I_D = -47 \text{ A}, V_{GS} = -10 \text{ V}$	 	50 450 100 195 84 18	110 910 210 400 110	ns ns ns ns
gd Gate-Drain Charge (Note 4, 5) 44 nC	Switchi t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_G = 25~\Omega \label{eq:reconstruction}$ (Note 4, 5) $V_{DS} = -48~V, I_D = -47~A, \label{eq:vgs}$ $V_{GS} = -10~V \label{eq:vgs}$ (Note 4, 5)	 	50 450 100 195 84 18	110 910 210 400 110	ns ns ns ns
gd Gate-Drain Charge (Note 4, 5) 44 nC Prain-Source Diode Characteristics and Maximum Ratings	Switchi t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd} Drain-S	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_G = 25~\Omega \label{eq:RG}$ (Note 4, 5) $V_{DS} = -48~V,~I_D = -47~A,~V_{GS} = -10~V \label{eq:VDS}$ (Note 4, 5)	 	50 450 100 195 84 18 44	110 910 210 400 110 	ns ns ns ns
Gate-Drain Charge (Note 4, 5) 44 nCertain-Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current47 A	$\begin{array}{c} \textbf{Switchi} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics ar Maximum Continuous Drain-Source Dio	$R_G = 25 \ \Omega$ $V_{DS} = -48 \ V, \ I_D = -47 \ A,$ $V_{GS} = -10 \ V$ (Note 4, 5) and Maximum Ratings and Forward Current	 	50 450 100 195 84 18 44	110 910 210 400 110 	ns ns ns nc nC
Grain-Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current Maximum Pulsed Drain-Source Diode Forward Current	Switchi t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd} Drain-S I _S	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics ar Maximum Continuous Drain-Source Diode Fall Time	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = -48 \text{ V}, I_D = -47 \text{ A},$ $V_{GS} = -10 \text{ V}$ (Note 4, 5) and Maximum Ratings ode Forward Current Forward Current	 	50 450 100 195 84 18 44	110 910 210 400 110 	ns ns ns nc nC
Gate-Drain Charge (Note 4, 5) 44 note (Prain-Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current Maximum Pulsed Drain-Source Diode Forward Current 47 A Maximum Pulsed Drain-Source Diode Forward Current 48 A Drain-Source Diode Forward Voltage V _{GS} = 0 V, I _S = -47 A 4.0 V	Switchi t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd} Drain-S	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics ar Maximum Continuous Drain-Source Diode F Drain-Source Diode Forward Voltage	$R_{G} = 25 \ \Omega$ $V_{DS} = -48 \ V, I_{D} = -47 \ A,$ $V_{GS} = -10 \ V$ $(Note 4, 5)$ $Note 4, 5$ $Note 5, 5$ $Note 6, 7$ $Note 6, 7$ $Note 6, 7$ $Note 6, 7$ $Note 7, 7$ N	 	50 450 100 195 84 18 44	110 910 210 400 110 -47 -188 -4.0	ns ns ns nC nC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 0.43mH, I_{AS} = -47A, V_{DD} = -25V, R_G = 25 Ω, Starting T_J = 25°C 3. I_{SD} ≤ -47A, di/dt ≤ 300A/µs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

Typical Characteristics

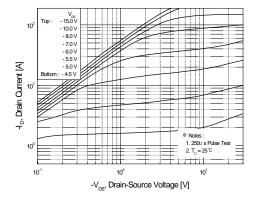


Figure 1. On-Region Characteristics

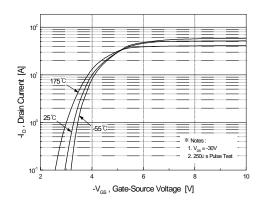


Figure 2. Transfer Characteristics

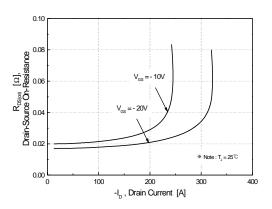


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

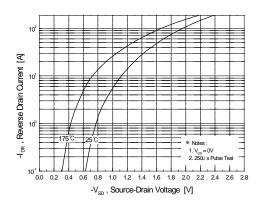


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

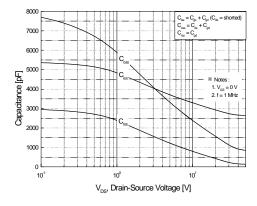


Figure 5. Capacitance Characteristics

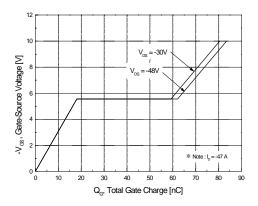


Figure 6. Gate Charge Characteristics

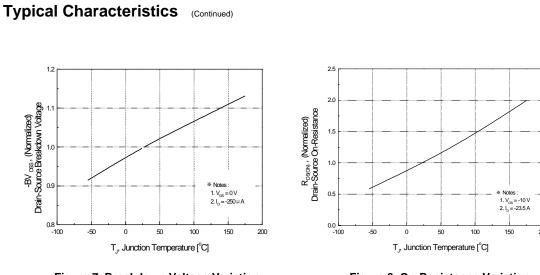


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature

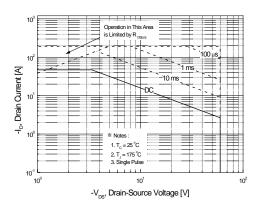


Figure 9. Maximum Safe Operating Area

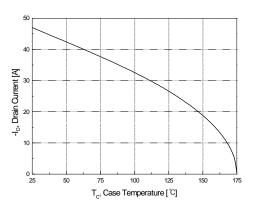


Figure 10. Maximum Drain Current vs. Case Temperature

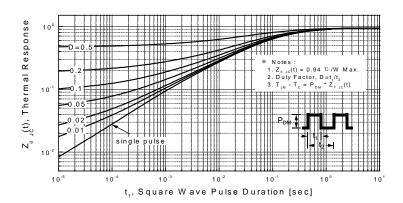
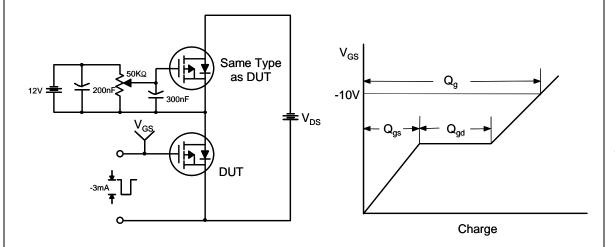
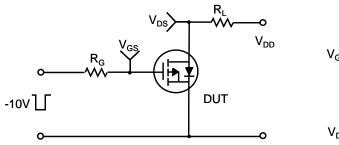


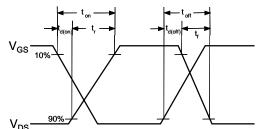
Figure 11. Transient Thermal Response Curve

Gate Charge Test Circuit & Waveform

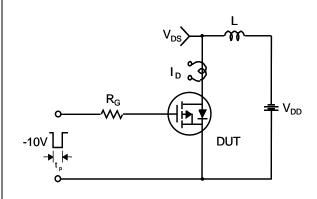


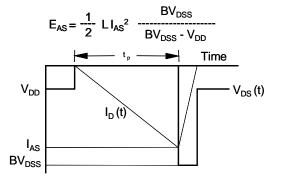
Resistive Switching Test Circuit & Waveforms



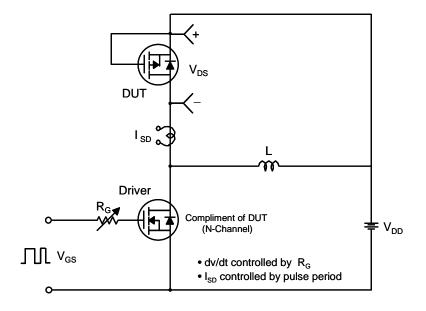


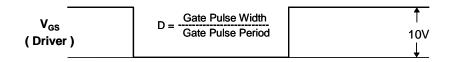
Unclamped Inductive Switching Test Circuit & Waveforms

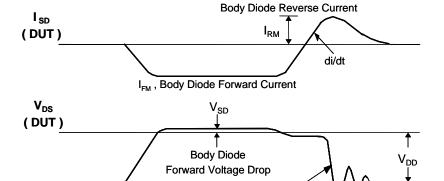




Peak Diode Recovery dv/dt Test Circuit & Waveforms



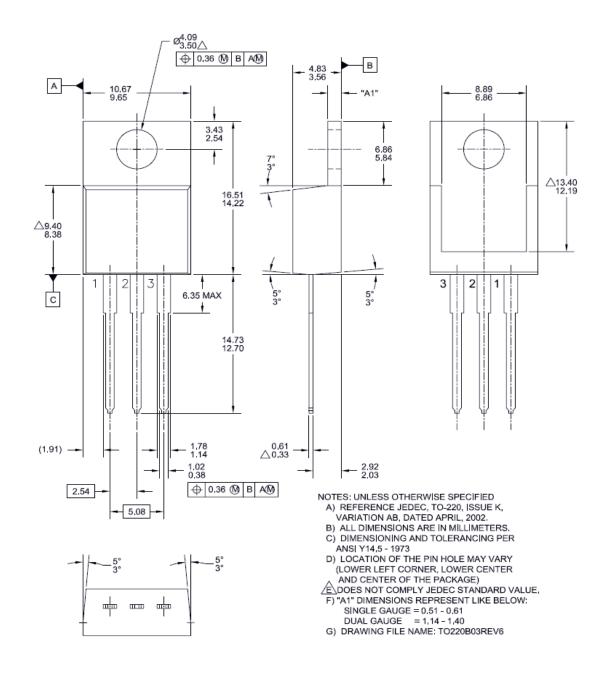




Body Diode Recovery dv/dt

Mechanical Dimensions

TO-220B03



Dimensions in Millimeters





TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

2Cool™ FPS™ AccuPower™ AX-CAP®* F-PFS™ FRFET®

Global Power ResourceSM BitSiC™ Build it Now™ Green Bridge™ CorePLUS™ Green FPS™ CorePOWER™ Green FPS™ e-Series™

CROSSVOLT™ Gmax™ CTL™ GTO™ Current Transfer Logic™ IntelliMAX™

DEUXPEED® ISOPLANAR™ Dual Cool™ Marking Small Speakers Sound Louder

EcoSPARK® and Better™ MegaBuck™ EfficentMax™ MICROCOUPLER™ ESBC™ MicroFET™

MicroPak™ MicroPak2™ Fairchild[®] MillerDrive™ Fairchild Semiconductor® MotionMax™ FACT Quiet Series™ mWSaver™ FACT[®] FAST® OptoHiT™ OPTOLOGIC® FastvCore™ OPTOPLANAR® FETBench™

(1)_® PowerTrench® PowerXS™

Programmable Active Droop™

 QS^{TM} Quiet Series™ RapidConfigure™

Saving our world, 1mW/W/kW at a time™

SignalWise™ SmartMax™ SMART START™

Solutions for Your Success™

STEALTH™ SuperFET®

SuperSOT™-3 SuperSOT™-6 SuperSOT™-8 SupreMOS® SyncFET™

Sync-Lock™

SYSTEM®' TinvBoost^T TinyBuck™ TinyCalc™ TinyLogic[®] TINYOPTO™ TinyPower™ TinyPWM™ TinyWire™ TranSiC[®] TriFault Detect™ TRUECURRENT®* uSerDes™

UHC® Ultra FRFET™ UniFET™ VCXTM VisualMax™ VoltagePlus™ XS™

*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY
FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 164